

Dual Notebook Power Supply N-Channel PowerTrench<sup>®</sup> SyncFet<sup>™</sup>

## **General Description**

The FDS6994S is designed to replace two single SO-8 MOSFETs and Schottky diode in synchronous DC:DC power supplies that provide various peripheral voltages for notebook computers and other battery powered electronic devices. FDS6994S contains two unique 30V, N-channel, logic level, PowerTrench MOSFETs designed to maximize power conversion efficiency.

The high-side switch (Q1) is designed with specific emphasis on reducing switching losses while the low-side switch (Q2) is optimized to reduce conduction losses. Q2 also includes an integrated Schottky diode using Fairchild's monolithic SyncFET technology.

## Features

• Q2: Optimized to minimize conduction losses Includes SyncFET Schottky body diode

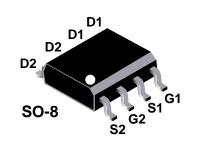
8.2A, 30V  $R_{DS(on)} = 15 \text{ m}\Omega @ V_{GS} = 10V$ 

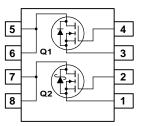
 $R_{DS(on)} = 17.5 \text{ m}\Omega @ V_{GS} = 4.5 \text{V}$ 

• Q1: Optimized for low switching losses Low gate charge (85.5 nC typical)

6.9A, 30V  $R_{DS(on)} = 21 \text{ m}\Omega @ V_{GS} = 10V$ 

 $R_{DS(on)} = 26 \text{ m}\Omega @ V_{GS} = 4.5 \text{V}$ 





## Absolute Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol		Parameter		Q2	Q1	Units
V <sub>DSS</sub>	Drain-Sourc	e Voltage		30	30	V
V <sub>GSS</sub>	Gate-Sourc	e Voltage		±16	±16	V
I <sub>D</sub>	Drain Curre	nt - Continuous	(Note 1a)	8.2	6.9	Α
		- Pulsed		30	20	
P <sub>D</sub>	Power Diss	pation for Dual Operation			2	W
	Power Diss	pation for Single Operation	n (Note 1a)	1	.6	
			(Note 1b)		1	
			(Note 1c)	0	.9	
T <sub>J</sub> , T <sub>STG</sub>	Operating a	nd Storage Junction Tem	perature Range	-55 to	+150	°C
Therma	l Charac	teristics				
$R_{\theta JA}$	Thermal Re	sistance, Junction-to-Aml	bient (Note 1a)	7	'8	°C/W
$R_{\theta JC}$	Thermal Re	sistance, Junction-to-Cas	e (Note 1)	4	0	°C/W
Packag	e Markin	g and Ordering	Information			·
Device I	Marking	Device	Reel Size	Tape wi	dth	Quantity
	994S	FDS6994S	13"	12mm		2500 units

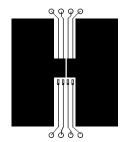
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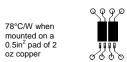
Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Cha	racteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$ $V_{GS} = 0 \text{ V}, I_D = 250 \text{ uA}$	Q2 Q1	30 30			V
<u>ΔBV<sub>DSS</sub></u> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = 1 mA, Referenced to 25°C $I_D$ = 250 µA, Referenced to 25°C	Q2 Q1		23 24		mV/°C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	Q2 Q1			500 1	μA
I <sub>GSS</sub>	Gate-Body Leakage	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	All			±100	nA
On Cha	racteristics (Note 2)						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 1 \text{ mA}$ $V_{DS} = V_{GS}, I_D = 250 \mu \text{A}$	Q2 Q1	1 1	1.5 1.9	3 3	V
$rac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 1 \text{ mA}$ , Referenced to 25°C $I_D = 250 \text{ uA}$ , Referenced to 25°C	Q2 Q1		-2 -5		mV/∘C
RDS(on)	Static Drain-Source On-Resistance		Q2 Q1		10 15 11 16 24	15 24 17.5 21 33.5	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, I_D = 6.2 \text{ A}$ $V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	Q2	30	19	26	
5(01)			Q1	20			A
<b>g</b> fs	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_D = 8.2 \text{ A}$ $V_{DS} = 10 \text{ V}, I_D = 6.9 \text{ A}$	Q2 Q1	42 41			S
Dynami	c Characteristics						
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 V, V_{GS} = 0 V,$ f = 1.0 MHz	Q2 Q1		2815 800		pF
C <sub>oss</sub>	Output Capacitance		Q2 Q1		540 205		pF
C <sub>rss</sub>	Reverse Transfer Capacitance		Q2 Q1		210 90		pF
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 15 mV, f = 1.0 MHz	Q2 Q1		2.8 2.6	4.9 4.6	Ω

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Мах	Units
Switchir	ng Characteristics (Note	2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, \text{ I}_{D} = 1 \text{ A},$	Q2		11	20	ns
		$V_{GS}$ = 10V, $R_{GEN}$ = 6 $\Omega$	Q1		11	20	
tr	Turn-On Rise Time		Q2		8	16	ns
			Q1		7	14	
t <sub>d(off)</sub>	Turn-Off Delay Time		Q2		50	80	ns
1		-	Q1		27	43	
t <sub>f</sub>	Turn-Off Fall Time		Q2 Q1		17 4	31 8	ns
Qg	Total Gate Charge	Q2:	Q1 Q2		25	35	nC
αg		$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 7.9 \text{ A}, \text{ V}_{GS} = 5 \text{ V}$	Q1		8	12	ne
Q <sub>gs</sub>	Gate-Source Charge		Q2		6		nC
90	5	Q1:	Q1		3		
Q <sub>gd</sub>	Gate-Drain Charge	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 6.5 \text{ A}, \text{ V}_{GS} = 5 \text{ V}$	Q2		7		nC
-			Q1		3		
Drain-S	ource Diode Character	istics and Maximum Ratings	5				
ls	Maximum Continuous Drain-S	Source Diode Forward Current	Q2			2.3	Α
			Q1			1.3	
t <sub>RR</sub>	Reverse Recovery Time	I <sub>F</sub> = 8.2 A,	Q2		25		ns
Q <sub>RR</sub>	Reverse Recovery Charge	$d_{iF}/d_t = 300 \text{ A}/\mu \text{s}$ (Note 3)			19		nC
t <sub>RR</sub>	Reverse Recovery Time	I <sub>F</sub> = 6.9 A,	Q2		23		ns
Q <sub>RR</sub>	Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A}/\mu \text{s} \qquad (\text{Note 3})$			10		nC
V <sub>SD</sub>	Drain-Source Diode Forward Voltage		Q2 Q1		0.4 0.53	7 1.2	V

Notes:

1.  $R_{\theta,JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta,JC}$  is guaranteed by design while  $R_{\theta,CA}$  is determined by the user's board design.





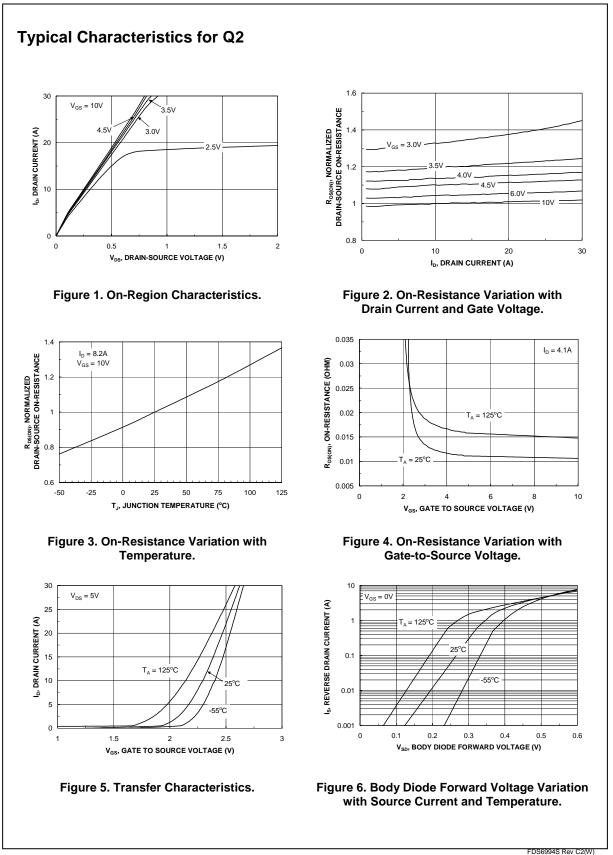
b) 125°C/W when mounted on a 0.02 in<sup>2</sup> pad of 2 oz copper c) 135°C/W when mounted on a minimum pad.

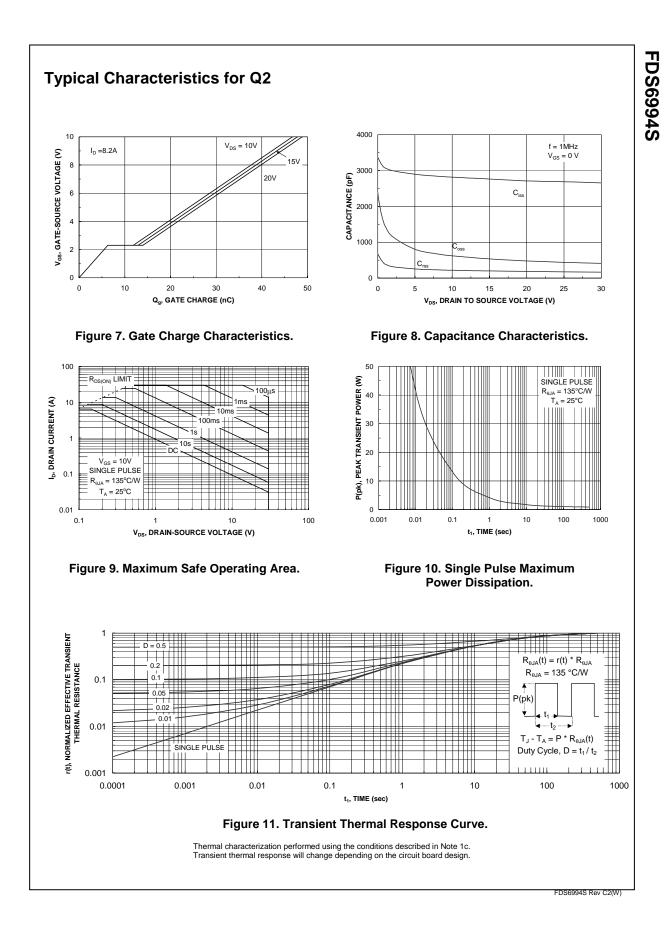
Scale 1 : 1 on letter size paper

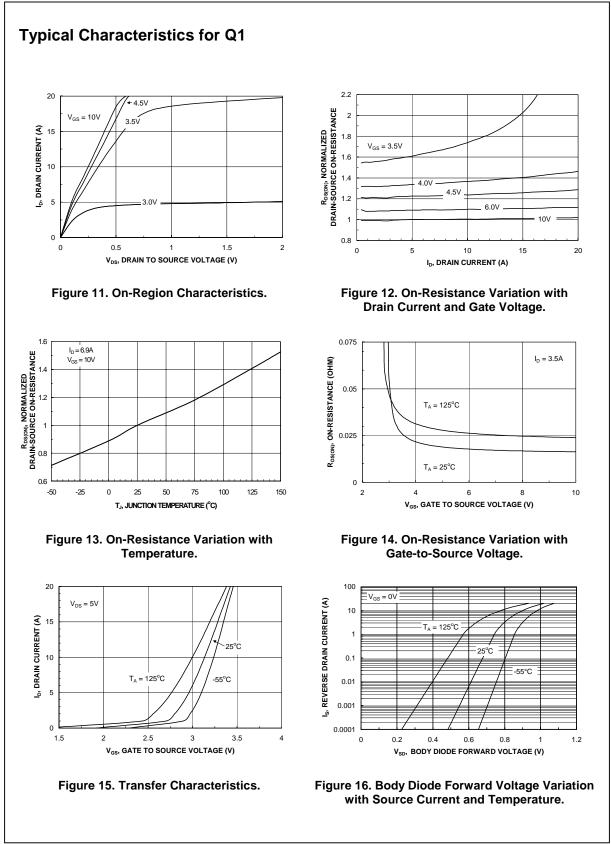
2. Pulse Test: Pulse Width < 300 $\mu$ s, Duty Cycle < 2.0%

3. See "SyncFET Schottky body diode characteristics" below.

a)

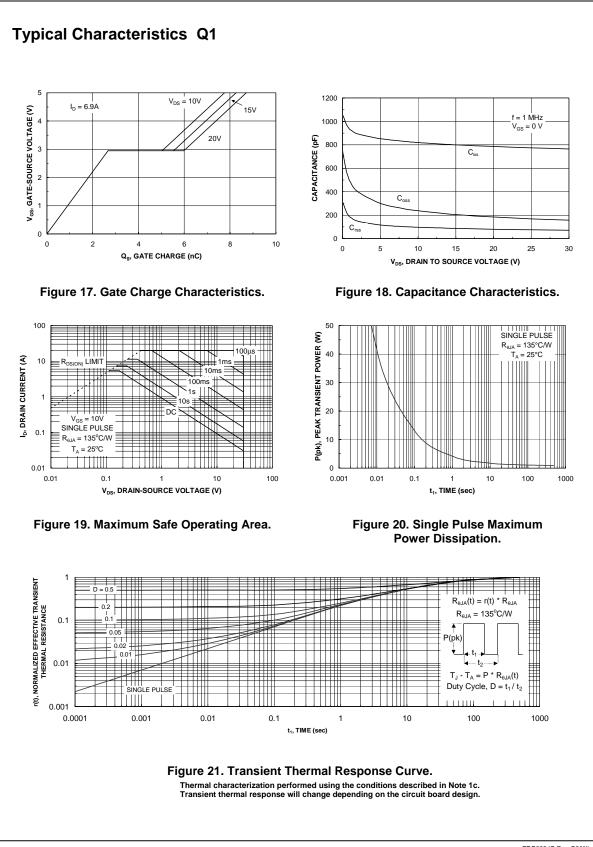






FDS6994S Rev C2(W)

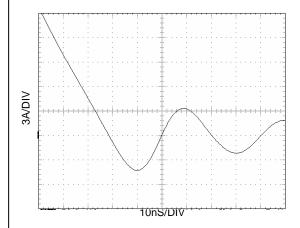
FDS6994S



### Typical Characteristics (continued) This section copied from FDS6984S datasheet

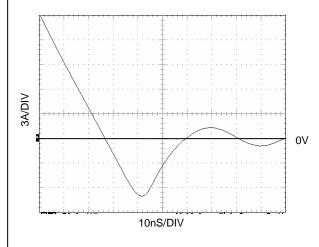
## SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 22 shows the reverse recovery characteristic of the FDS6994S.



## Figure 22. FDS6994S SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 23 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS6690A).





Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

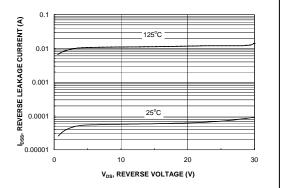


Figure 24. SyncFET body diode reverse leakage versus drain-source voltage and temperature.



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